

March 2015

# FDD8778/FDU8778

# N-Channel PowerTrench® MOSFET

**25V**, **35A**, **14m**Ω

#### **Features**

- Max  $r_{DS(on)}$  = 14.0m $\Omega$  at  $V_{GS}$  = 10V,  $I_D$  = 35A
- Max  $r_{DS(on)}$  = 21.0m $\Omega$  at  $V_{GS}$  = 4.5V,  $I_D$  = 33A
- Low gate charge:  $Q_{g(TOT)} = 12.6nC(Typ)$ ,  $V_{GS} = 10V$
- Low gate resistance
- RoHS compliant

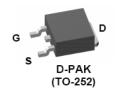


## **General Description**

This N-Channel MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers. It has been optimized for low gate charge, low  $r_{\text{DS(on)}}$  and fast switching speed.

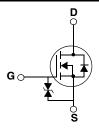
# **Application**

- DC-DC for Desktop Computers and Servers
- VRM for Intermediate Bus Architecture









### MOSFET Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
$V_{DS}$	Drain to Source Voltage		25	V
$V_{GS}$	Gate to Source Voltage		±20	V
	Drain Current -Continuous (Package Limited)		35	
$I_D$	-Continuous (Die Limited)		40	Α
	-Pulsed	(Note 1)	145	
E <sub>AS</sub>	Single Pulse Avalanche Energy	(Note 2)	24	mJ
$P_{D}$	Power Dissipation		39	W
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature		-55 to 175	°C

# **Thermal Characteristics**

$R_{\theta JC}$	Thermal Resistance, Junction to Case TO-252,TO-251	3.8	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient TO-252,TO-251	100	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient TO-252,1in <sup>2</sup> copper pad area	52	°C/W

# **Package Marking and Ordering Information**

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDD8778	FDD8778	TO-252AA	13"	16mm	2500 units
FDU8778	FDU8778	TO-251AA	N/A(Tube)	N/A	75 units
FDU8778	FDU8778_F071	TO-251AA	N/A(Tube)	N/A	75 units

Electrical	Characteristics	T <sub>.1</sub> = 25°C unless otherwise noted
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Symbol	Parameter Test Conditions		IVIIII	тур	IVIAX	Units
Off Chara	acteristics					
$BV_{DSS}$	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0V$	25			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = 250μA, referenced to 25°C		17.2		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = 20V,$ $V_{GS} = 0V$ $T_{J} = 150^{\circ}C$			1 250	μА
I <sub>GSS</sub>	Gate to Source Leakage Current	V <sub>GS</sub> = ±20V			±10	μΑ

#### **On Characteristics**

V <sub>GS(th)</sub>	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$	1.2	1.5	2.5	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D$ = 250 $\mu$ A, referenced to 25°C		-5.3		mV/°C
r <sub>DS(on)</sub> Drain to Source On Resistance	$V_{GS} = 10V, I_D = 35A$		11.6	14.0		
	Drain to Source On Resistance	$V_{GS} = 4.5V, I_D = 33A$		15.7	21.0	mΩ
	Brain to course on resistance	V <sub>GS</sub> = 10V, I <sub>D</sub> = 35A T <sub>J</sub> = 175°C		18.2	23.8	11152

### **Dynamic Characteristics**

C <sub>iss</sub>	Input Capacitance	101/11/	635	845	pF
Coss	Output Capacitance	V <sub>DS</sub> = 13V, V <sub>GS</sub> = 0V, f = 1MHz	160	215	pF
C <sub>rss</sub>	Reverse Transfer Capacitance	1 - 11411 12	108	162	pF
$R_g$	Gate Resistance	f = 1MHz	1.3		Ω

# **Switching Characteristics**

$t_{d(on)}$	Turn-On Delay Time		6	12	ns
t <sub>r</sub>	Rise Time	$V_{DD} = 13V$ , $I_{D} = 35A$ $V_{GS} = 10V$ , $R_{GS} = 27\Omega$	22	35	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	V <sub>GS</sub> = 10V, K <sub>GS</sub> = 2712	43	69	ns
t <sub>f</sub>	Fall Time		32	51	ns
$Q_{g(TOT)}$	Total Gate Charge at 10V	V <sub>GS</sub> = 0V to 10V	12.6	18	nC
$Q_{g(5)}$	Total Gate Charge at 5V	$V_{GS} = 0V \text{ to } 5V$ $V_{DD} = 13V$ $I_{D} = 35A$	6.7	9.4	nC
$Q_{gs}$	Gate to Source Gate Charge	$I_D = 35A$ $I_0 = 1.0 \text{mA}$	2.1		nC
Q <sub>gd</sub>	Gate to Drain "Miller" Charge	- ig 1.511# (	3.2		nC

#### **Drain-Source Diode Characteristics**

		$V_{GS} = 0V, I_S = 35A$	1.03	1.25	V
	V <sub>GS</sub> = 0V, I <sub>S</sub> = 15A	0.89	1.2	v	
t <sub>rr</sub>	Reverse Recovery Time	I <sub>F</sub> = 35A, di/dt = 100A/μs	25	38	ns
Q <sub>rr</sub>	Reverse Recovery Charge	$I_F = 35A$ , di/dt = 100A/ $\mu$ s	17	26	nC

Notes:
1: Pulse time < 300µs, Duty cycle = 2%.
2: Starting T<sub>J</sub> = 25°C, L = 0.1mH, I<sub>AS</sub> = 22A, V<sub>DD</sub> = 23V, V<sub>GS</sub> = 10V.

#### **Typical Characteristics** T<sub>J</sub> = 25°C unless otherwise noted

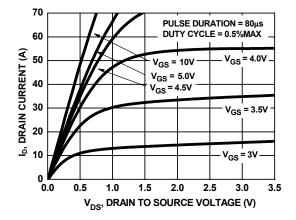


Figure 1. On Region Characteristics

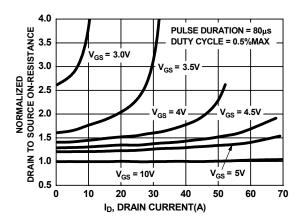


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

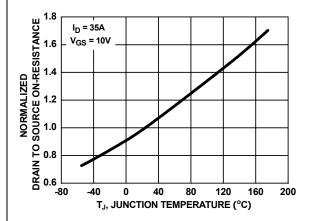


Figure 3. Normalized On Resistance vs Junction Temperature

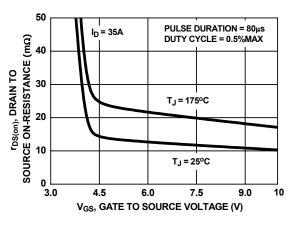


Figure 4. On-Resistance vs Gate to Source Voltage

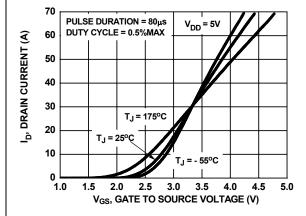


Figure 5. Transfer Characteristics

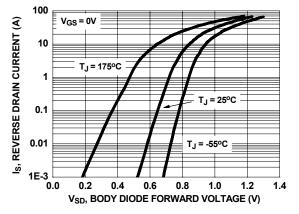


Figure 6. Source to Drain Diode Forward Voltage vs Source Current



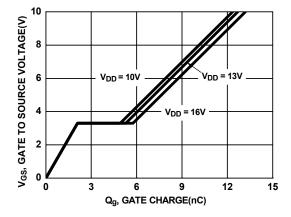


Figure 7. Gate Charge Characteristics

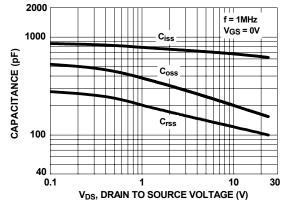


Figure 8. Capacitance vs Drain to Source Voltage

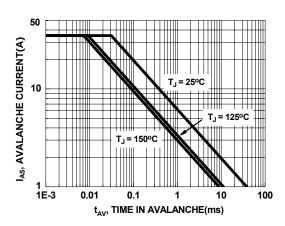


Figure 9. Unclamped Inductive Switching Capability

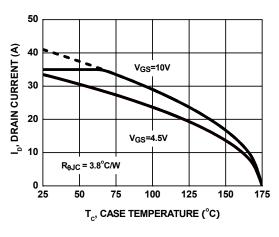


Figure 10. Maximum Continuous Drain Current vs Case Temperature

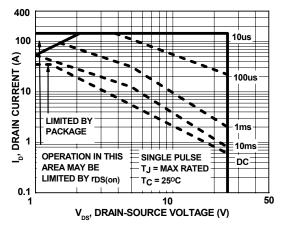


Figure 11. Forward Bias Safe Operating Area

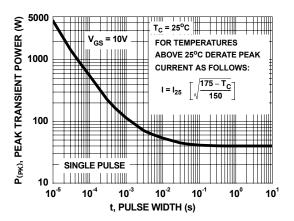


Figure 12. Single Pulse Maximum Power Dissipation

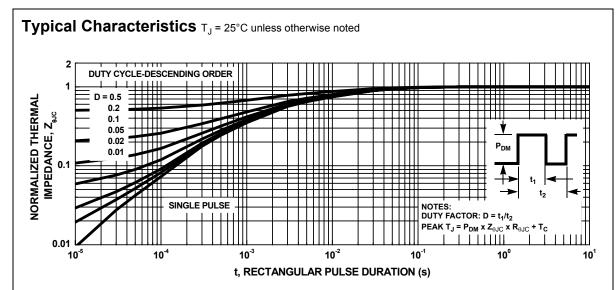
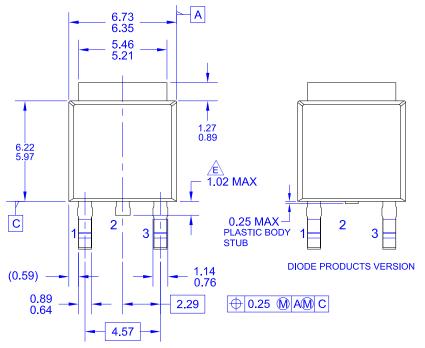
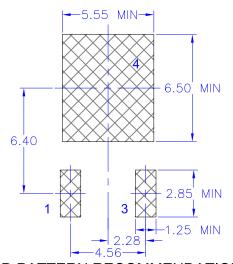
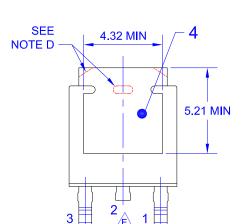


Figure 13. Transient Thermal Response Curve



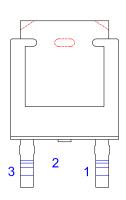


LAND PATTERN RECOMMENDATION

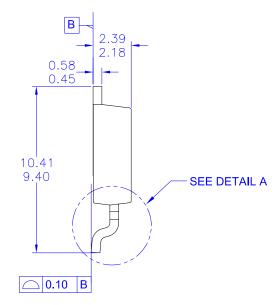


NON-DIODE PRODUCTS VERSION





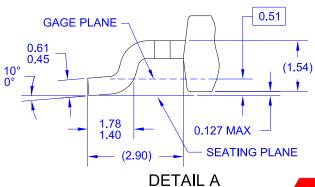
DIODE PRODUCTS VERSION



#### NOTES: UNLESS OTHERWISE SPECIFIED

- A) THIS PACKAGE CONFORMS TO JEDEC, TO-252,
- ISSUE C, VARIATION AA.

  B) ALL DIMENSIONS ARE IN MILLIMETERS.
  C) DIMENSIONING AND TOLERANCING PER ASME Y14.5M-2009.
- D) SUPPLIER DEPENDENT MOLD LOCKING HOLES OR CHAMFERED CORNERS OR EDGE PROTRUSION.
- E) TRIMMED CENTER LEAD IS PRESENT ONLY FOR DIODE PRODUCTS F) DIMENSIONS ARE EXCLUSSIVE OF BURSS,
  - MOLD FLASH AND TIE BAR EXTRUSIONS.
- G) LAND PATTERN RECOMENDATION IS BASED ON IPC7351A STD TO228P991X239-3N.
- H) DRAWING NUMBER AND REVISION: MKT-TO252A03REV10



(ROTATED -90°) SCALE: 12X







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